

# SN54BCT125A, SN74BCT125A QUADRUPLE BUS BUFFER GATES WITH 3-STATE OUTPUTS

SCBS032E – SEPTEMBER 1988 – REVISED APRIL 1994

- State-of-the-Art BiCMOS Design Significantly Reduces  $I_{CCZ}$
- 3-State Outputs Drive Bus Lines or Buffer Memory Address Registers
- Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK) and Flatpacks (W), and Standard Plastic and Ceramic 300-mil DIPs (J, N)

## description

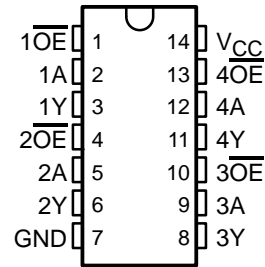
The 'BCT125A bus buffer features independent line drivers with 3-state outputs. Each output is disabled when the associated output-enable ( $\overline{OE}$ ) input is high.

The SN54BCT125A is characterized for operation over the full military temperature range of  $-55^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ . The SN74BCT125A is characterized for operation from  $0^{\circ}\text{C}$  to  $70^{\circ}\text{C}$ .

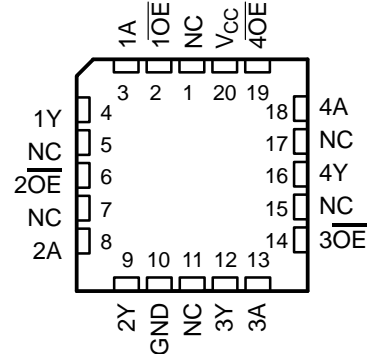
FUNCTION TABLE  
(each buffer)

| INPUTS          |   | OUTPUT |
|-----------------|---|--------|
| $\overline{OE}$ | A | Y      |
| L               | H | H      |
| L               | L | L      |
| H               | X | Z      |

SN54BCT125A . . . J OR W PACKAGE  
SN74BCT125A . . . D OR N PACKAGE  
(TOP VIEW)

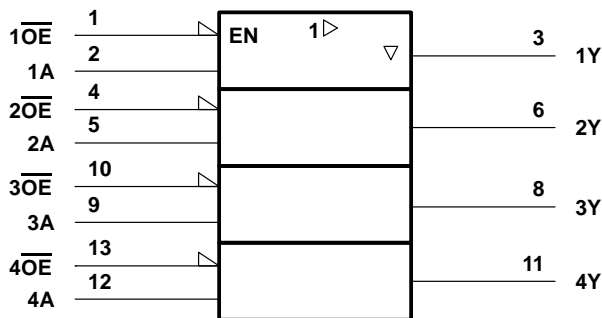


SN54BCT125A . . . FK PACKAGE  
(TOP VIEW)



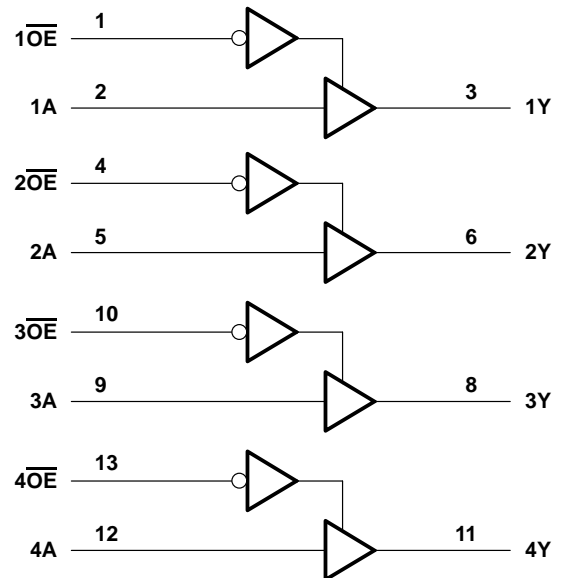
NC – No internal connection

## logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

## logic diagram (positive logic)



Pin numbers shown are for the J, N, and W packages.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS  
INSTRUMENTS**

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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

|   |                     |
|---|---------------------|
| Supply voltage range, $V_{CC}$  | – 0.5 V to 7 V      |
| Input voltage range, $V_I$ (see Note 1)                                       | – 0.5 V to 7 V      |
| Voltage range applied to any output in the disabled or power-off state, $V_O$ | – 0.5 V to 5.5 V    |
| Voltage range applied to any output in the high state, $V_O$                  | – 0.5 V to $V_{CC}$ |
| Current into any output in the low state: SN54BCT125A                         | 96 mA               |
| SN74BCT125A   | 128 mA              |
| Operating free-air temperature range: SN54BCT125A                             | – 55°C to 125°C     |
| SN74BCT125A   | 0°C to 70°C         |
| Storage temperature range   | – 65°C to 150°C     |

<sup>†</sup> Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

## recommended operating conditions

|          |                                | SN54BCT125A |     |     | SN74BCT125A |     |     | UNIT |
|----------|--------------------------------|-------------|-----|-----|-------------|-----|-----|------|
|          |                                | MIN         | NOM | MAX | MIN         | NOM | MAX |      |
| $V_{CC}$ | Supply voltage                 | 4.5         | 5   | 5.5 | 4.5         | 5   | 5.5 | V    |
| $V_{IH}$ | High-level input voltage       | 2           |     |     | 2           |     |     | V    |
| $V_{IL}$ | Low-level input voltage        |             |     | 0.8 |             |     | 0.8 | V    |
| $I_{IK}$ | Input clamp current            |             |     | –18 |             |     | –18 | mA   |
| $I_{OH}$ | High-level output current      |             |     | –12 |             |     | –15 | mA   |
| $I_{OL}$ | Low-level output current       |             |     | 48  |             |     | 64  | mA   |
| $T_A$    | Operating free-air temperature | –55         |     | 125 | 0           |     | 70  | °C   |



# SN54BCT125A, SN74BCT125A QUADRUPLE BUS BUFFER GATES WITH 3-STATE OUTPUTS

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER         | TEST CONDITIONS   |                          | SN54BCT125A |      |      | SN74BCT125A |      |      | UNIT          |
|-------------------|---|--------------------------|-------------|------|------|-------------|------|------|---------------|
|                   |   |                          | MIN         | TYP† | MAX  | MIN         | TYP† | MAX  |               |
| $V_{IK}$          | $V_{CC} = 4.5\text{ V}$ ,<br>$I_I = -18\text{ mA}$                |                          |             |      | -1.2 |             |      | -1.2 | V             |
| $V_{OH}$          | $V_{CC} = 4.5\text{ V}$   | $I_{OH} = -3\text{ mA}$  | 2.4         | 3.3  |      | 2.4         | 3.3  |      | V             |
|                   |   | $I_{OH} = -12\text{ mA}$ | 2           | 3.2  |      |             |      |      |               |
|                   |   | $I_{OH} = -15\text{ mA}$ |             |      |      | 2           | 3.1  |      |               |
| $V_{OL}$          | $V_{CC} = 4.5\text{ V}$   | $I_{OL} = 48\text{ mA}$  |             | 0.38 | 0.55 |             |      |      | V             |
|                   |   | $I_{OL} = 64\text{ mA}$  |             |      |      |             | 0.42 | 0.55 |               |
| $I_I$             | $V_{CC} = 0$ ,<br>$V_I = 7\text{ V}$                              |                          |             |      | 0.1  |             |      | 0.1  | mA            |
| $I_{IH}$          | $V_{CC} = 5.5\text{ V}$ ,<br>$V_I = 2.7\text{ V}$                 |                          |             |      | 35   |             |      | 25   | $\mu\text{A}$ |
| $I_{IL}$          | $V_{CC} = 5.5\text{ V}$ ,<br>$V_I = 0.5\text{ V}$                 |                          |             |      | -20  |             |      | -20  | $\mu\text{A}$ |
| $I_{OZH}$         | $V_{CC} = 5.5\text{ V}$ ,<br>$V_O = 2.7\text{ V}$                 |                          |             |      | 50   |             |      | 50   | $\mu\text{A}$ |
| $I_{OZL}$         | $V_{CC} = 5.5\text{ V}$ ,<br>$V_O = 0.5\text{ V}$                 |                          |             |      | -50  |             |      | -50  | $\mu\text{A}$ |
| $I_{OS}^\ddagger$ | $V_{CC} = 5.5\text{ V}$ ,<br>$V_O = 0$                            |                          | -100        |      | -225 | -100        |      | -225 | mA            |
| $I_{CCH}$         | $V_{CC} = 5.5\text{ V}$ ,<br>Outputs open                         |                          |             | 19   | 31   |             | 19   | 31   | mA            |
| $I_{CCL}$         | $V_{CC} = 5.5\text{ V}$ ,<br>Outputs open                         |                          |             | 46   | 49   |             | 46   | 49   | mA            |
| $I_{CCZ}$         | $V_{CC} = 5.5\text{ V}$ ,<br>Outputs open                         |                          |             | 6    | 14   |             | 6    | 14   | mA            |
| $C_i$             | $V_{CC} = 5\text{ V}$ ,<br>$V_I = 2.5\text{ V}$ or $0.5\text{ V}$ |                          |             | 4    |      |             | 4    |      | pF            |
| $C_o$             | $V_{CC} = 5\text{ V}$ ,<br>$V_O = 2.5\text{ V}$ or $0.5\text{ V}$ |                          |             | 9    |      |             | 9    |      | pF            |

† All typical values are at  $V_{CC} = 5\text{ V}$ .

‡ Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

## switching characteristics (see Note 2)

| PARAMETER        | FROM<br>(INPUT) | TO<br>(OUTPUT) | V <sub>CC</sub> = 5 V,<br>C <sub>L</sub> = 50 pF,<br>R1 = 500 Ω,<br>R2 = 500 Ω,<br>T <sub>A</sub> = 25°C |     |      | V <sub>CC</sub> = 4.5 V to 5.5 V,<br>C <sub>L</sub> = 50 pF,<br>R1 = 500 Ω,<br>R2 = 500 Ω,<br>T <sub>A</sub> = MIN to MAX§ |      |             |      | UNIT |
|------------------|-----------------|----------------|--|-----|------|--|------|-------------|------|------|
|                  |                 |                | ‘BCT125A   |     |      | SN54BCT125A  |      | SN74BCT125A |      |      |
|                  |                 |                | MIN  | TYP | MAX  | MIN  | MAX  | MIN         | MAX  |      |
| t <sub>PLH</sub> | A               | Y              | 1.6  | 3.5 | 5.2  | 1.6  | 6    | 1.6         | 5.7  | ns   |
| t <sub>PHL</sub> |                 |                | 2.7  | 5   | 6.9  | 2.7  | 8    | 2.7         | 7.7  |      |
| t <sub>PZH</sub> | OE              | Y              | 3.4  | 6.7 | 9    | 3.4  | 11.1 | 3.4         | 10.3 | ns   |
| t <sub>PZL</sub> |                 |                | 5  | 8.2 | 10.4 | 5  | 12.8 | 5           | 11.7 |      |
| t <sub>PHZ</sub> | OE              | Y              | 3  | 5.8 | 7.4  | 3  | 9.4  | 3           | 8.9  | ns   |
| t <sub>PLZ</sub> |                 |                | 2.8  | 5.5 | 7.3  | 2.8  | 9.9  | 2.8         | 8.6  |      |

§ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



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